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Contents

Articles

NIST High Accuracy Reference Reflectometer-Spectrometer	James E. Proctor and P. Yvonne Barnes	619
An Oil-Bath-Based 293 K to 473 K Blackbody Source	Joel B. Fowler	629
Comparative High Voltage Impulse Measurement	Gerald J. FitzPatrick and Edward F. Kelley	639
Ultrasonic Power Output Measurement by Pulsed Radiation Pressure	Steven E. Fick and Franklin R. Breckenridge	659
Corrections for Wavelength Variations in Precision Interferometric Displacement Measurements	Jack Stone, Steven D. Phillips, and Gary A. Mandolfo	671
Melting and Vaporization of the 1223 Phase in the System (Tl-Pb-Ba-Sr-Ca-Cu-O)	porization of the 1223 Phase in the b-Ba-Sr-Ca-Cu-O)L. P. Cook, W. Wong-Ng, and P. Paranthaman	
Improved Wavelengths and Energy Levels of Doubly-Ionized Argon (Ar III)	Victor Kaufman and Ward Whaling	691

Conference Reports

NIST Tutorial/Workshop on Lattice Gas and Boltzmann Methods	Nicos S. Martys	705
NIST Speciation Workshop	M. K. Schultz, W. C. Burnett,	707
	K. G. W. Inn, J. W. L. Thomas,	
	and Zhichao Lin	

News Briefs

GENERAL DEVELOPMENTS

Partners to Agree on PKI Basics DARTS Scores a Bullseye in Evaluating Stress A New "Twist" Solves an Old Problem

Papers on Trapped Ions and Laser Cooling Published Better Lab Accreditation Envisioned for Future High-Altitude Sensing Gets Lift in Accuracy NIST, Russian Agency Pledge Scientific Cooperation Spectroscopic Reference Data Now New and Improved	718
United States, South Africa to Cooperate in Science and Technology Specialized Radiometer Developed for Lasers Guide to Electronics Packaging at NIST Published Partners Develop Ultrasensitive Bolometer	719
Clarify Screw-Thread Standards, Report Says Mideast Neighbors Seek Standards Harmony U.S., Egypt Team on Standards/Metrology Effort	720
Updated Catalog Highlights New NIST Technologies Federal R&D Programs Report Now On-line Energy-Related Inventions Program Makes Recommendations NIST Completes Polarization Mode Dispersion Round Robin Using NIST Artifact	721
New Technique for Analyzing Gas-Particle Flows Shedding Light on Surface Reactions Six NIST Authors Contribute Prominently to New AMO Physics Handbook Near-Field Scanning Optical Microscopy: Nanometer-Scale Characterization of Optical Fields	722
Hydration Reaction of Neutron Scattering Used to Study the Model Cement Compound Determination of Thermal Conductivity of Layered Ceramic Coatings	723
Polymer Blends and Processing Center Established NIST Melting Studies for Improved Superconducting Oxide Wires and Tapes NIST Developed Electron Holography Software Available	724
Matrix Market Unveiled NIST Participates in Video-on-Demand Interoperability Test NIST Explores Distributed Communication Methods for Use in Health Care Applications NIST and SEMATECH Join Forces to Produce an Electronic Statistical Handbook Optical Character Recognition Research Advances	725
Release of Sparse Matrix Software SQL Test Suite, Version 6.0, Beta Testing Goal of New Partnership: Safer Cars Indiana Now Linked to Nationwide Network	726
Connections with Reflections Cause Errors Electronic Materials Group Urges R&D Cooperation Stressed Out Measuring Force? Then Vibrate! Consortium Seeks Best Wear Resistance for Implants New Tool May Lead to Overlay Standards	727
Proposals Sought for Precision Measurement Grants Comments Sought on Wood Products Program Fastener Program Under Way to Protect Public	728
Smokies Go Solar With NIST Hot Water Device	729

STANDARD REFERENCE MATERIALS	729
SRM 2073A, Sinusoidal Roughness Specimens, Certified and Released NIST Assigns Values for Methylmercury in Several Environmental SRMs	
Special Brochures Available for 16 Program Groups	730
Calendar	731